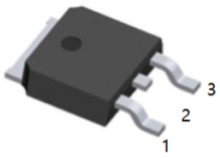
60V N-Channel MOSFET

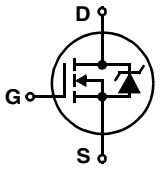
Features

- V_{DS}(V) = 60V
- I_D =50A (V_{GS} = 10V)
- $R_{DS(ON)}$ <14.4mΩ (V_{GS} = 10V)
- 175°C operating temperature



1.G 2.D 3.S

TO-252(DPAK) top view



MOSFET Maximum Ratings

at T_j=25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I_D	T_C=25 °C, V_{GS}=10 V	50[1)]	A
		T_C=100 °C, V_{GS}=10 V[2)]	49	
Pulsed drain current[2)]	$I_{D,pulse}$	T_C=25 °C	200	
Avalanche energy, single pulse	E_{AS}	I_D=50A	240	mJ
Gate source voltage	V_{GS}		±20	V
Power dissipation	P_{tot}	T_C=25 °C	136	W
Operating and storage temperature	T_j, T_{stg}		-55 ... +175	°C
IEC climatic category; DIN IEC 68-1			55/175/56	

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Thermal characteristics						
Thermal resistance, junction - case	R_{thJC}		-	-	1.1	K/W
Thermal resistance, junction - ambient, leaded	R_{thJA}		-	-	100	
SMD version, device on PCB	R_{thJA}	minimal footprint	-	-	75	
		6 cm^2 cooling area[3)]	-	-	50	
Electrical characteristics, at T_j=25 °C, unless otherwise specified						
Static characteristics						
Drain-source breakdown voltage	$V_{(BR)DSS}$	V_{GS}=0 V, I_D= 1 mA	60	-	-	V
Gate threshold voltage	$V_{GS(th)}$	V_{DS}=V_{GS}, I_D=80 µA	2.1	3.0	4.0	
Zero gate voltage drain current	I_{DSS}	V_{DS}=55 V, V_{GS}=0 V, T_j=25 °C	-	0.01	1	µA
		V_{DS}=55 V, V_{GS}=0 V, T_j=125 °C[2)]	-	1	100	
Gate-source leakage current	I_{GSS}	V_{GS}=20 V, V_{DS}=0 V	-	1	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	V_{GS}=10 V, I_D=32 A,	-	10.8	14.4	mΩ

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Dynamic characteristics[2]						
Input capacitance	C_{iss}	V_{GS}=0 V, V_{DS}=25 V, f=1 MHz	-	1485	-	pF
Output capacitance	C_{oss}		-	464	-	
Reverse transfer capacitance	C_{rss}		-	167	-	
Turn-on delay time	$t_{d(on)}$	V_{DD}=30 V, V_{GS}=10 V, I_D=50 A, R_G=7.5 Ω	-	13	-	ns
Rise time	t_r		-	29	-	
Turn-off delay time	$t_{d(off)}$		-	30	-	
Fall time	t_f		-	19	-	
Gate Charge Characteristics[2]						
Gate to source charge	Q_{gs}	V_{DD}=44 V, I_D=50 A, V_{GS}=0 to 10 V	-	8	11	nC
Gate to drain charge	Q_{gd}		-	16	24	
Gate charge total	Q_g		-	39	52	
Gate plateau voltage	$V_{plateau}$		-	5.4	-	V
Reverse Diode						
Diode continous forward current[2]	I_S	T_C=25 °C	-	-	50	A
Diode pulse current[2]	$I_{S,pulse}$		-	-	200	
Diode forward voltage	V_{SD}	V_{GS}=0 V, I_F=50 A, T_j=25 °C	-	1	1.3	V
Reverse recovery time[2]	t_{rr}	V_R=30 V, I_F=I_S, di_F/dt=100 A/µs	-	45	-	ns
Reverse recovery charge[2]	Q_{rr}	V_R=30 V, I_F=I_S, di_F/dt=100 A/µs	-	74	-	nC

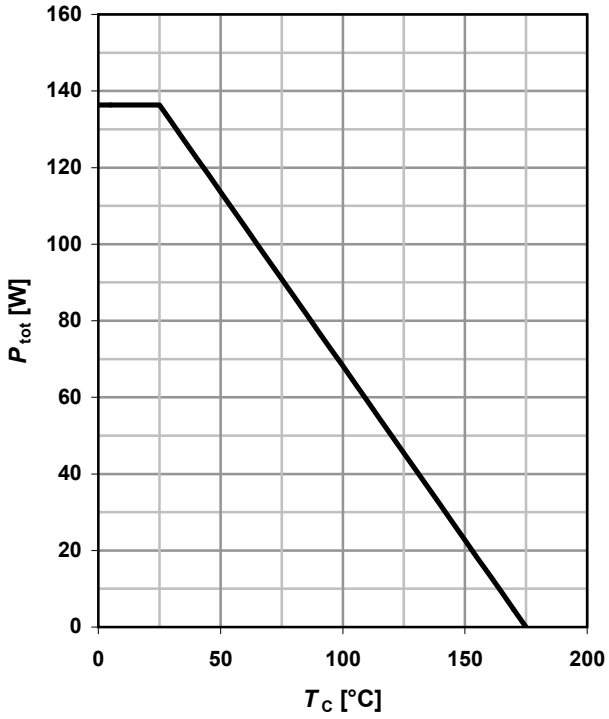
[1] Current is limited by bondwire; with an RthJC=1.1 K/W the chip is able to carry 69 A.

[2] Defined by design. Not subject to production test.

[3] Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm^2 (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.

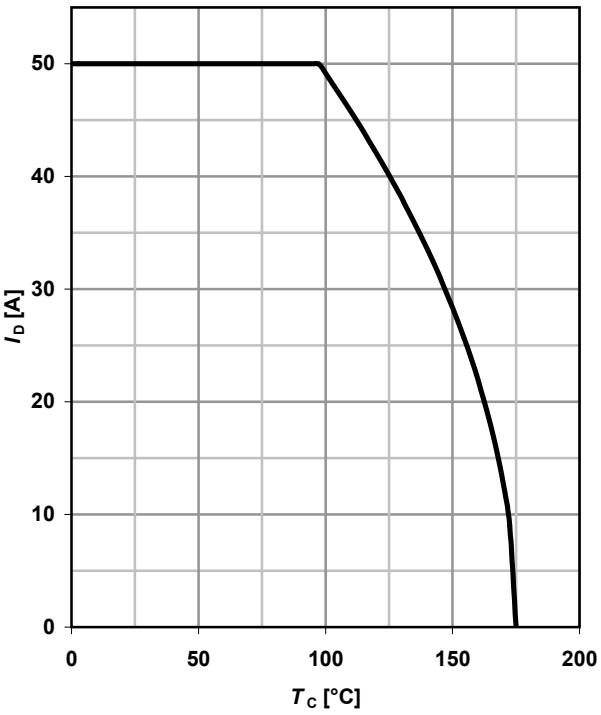
1 Power dissipation

$P_{tot} = f(T_C)$; $V_{GS} \geq 6$ V



2 Drain current

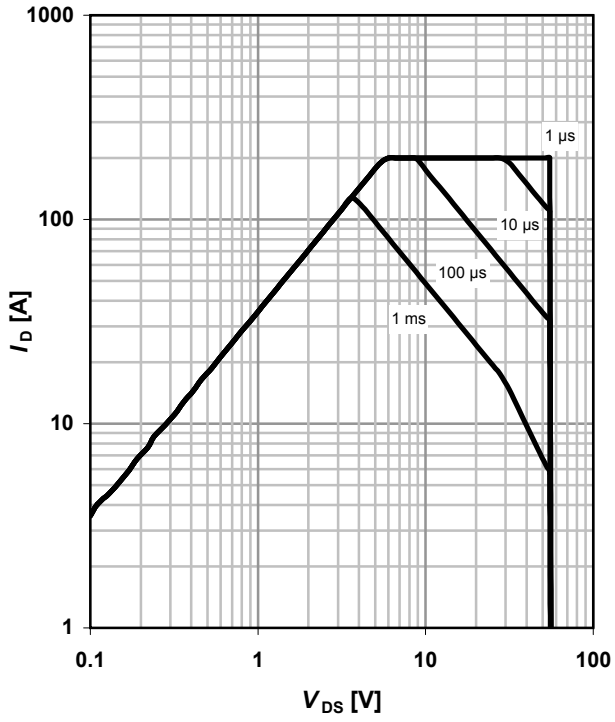
$I_D = f(T_C)$; $V_{GS} \geq 10$ V



3 Safe operating area

$I_D = f(V_{DS})$; $T_C = 25$ °C; $D = 0$

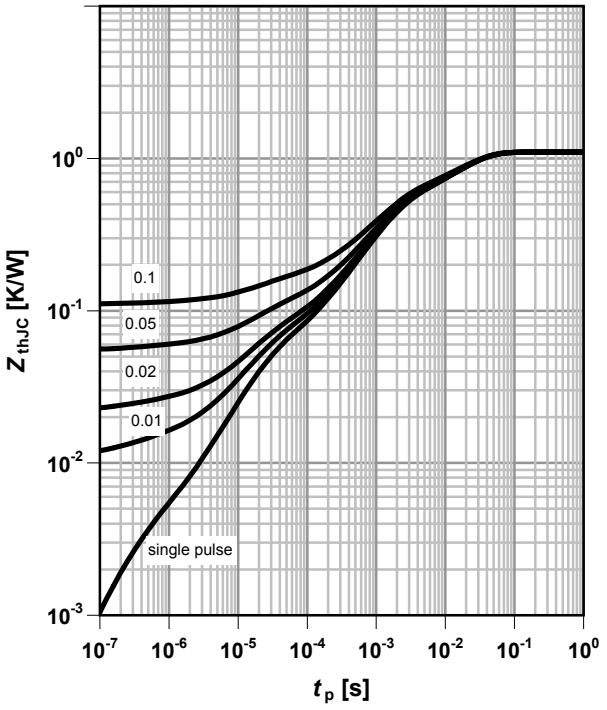
parameter: t_p



4 Max. transient thermal impedance

$Z_{thJC} = f(t_p)$

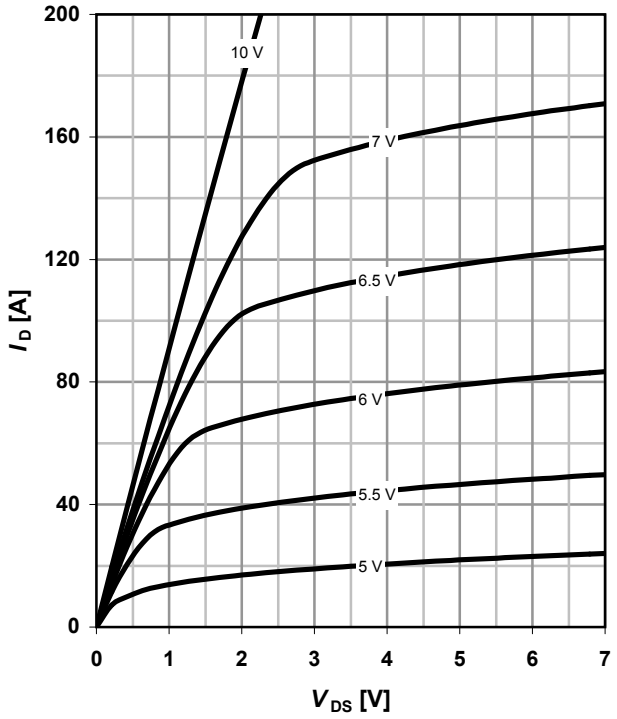
parameter: $D = t_p/T$



5 Typ. output characteristics

$I_D = f(V_{DS})$; $T_j = 25$ °C

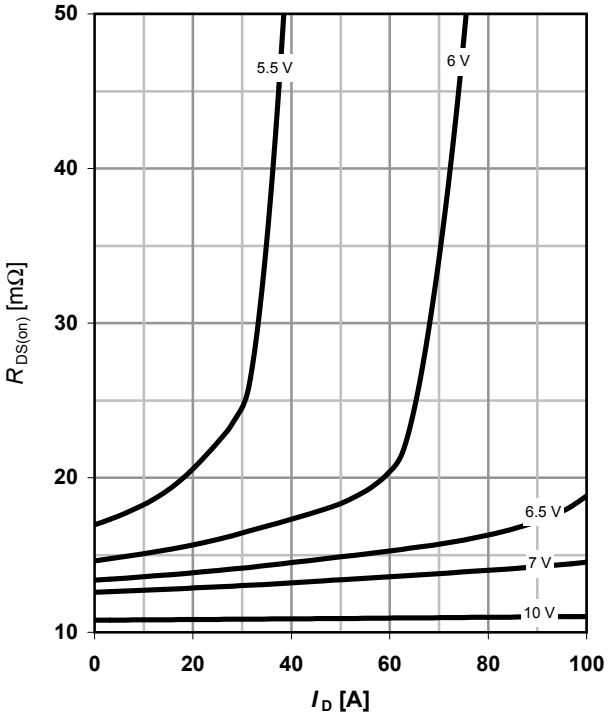
parameter: V_{GS}



6 Typ. drain-source on-state resistance

$R_{DS(on)} = (I_D)$; $T_j = 25$ °C

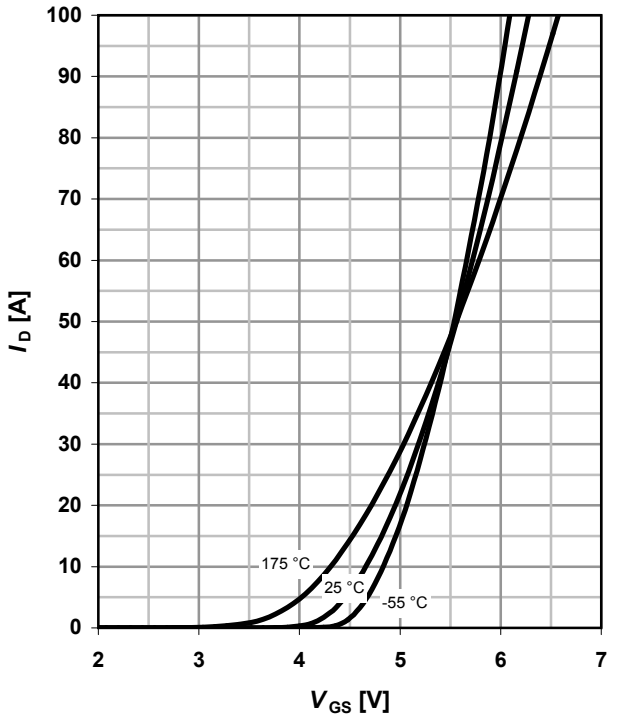
parameter: V_{GS}



7 Typ. transfer characteristics

$I_D = f(V_{GS})$; $V_{DS} = 6$V

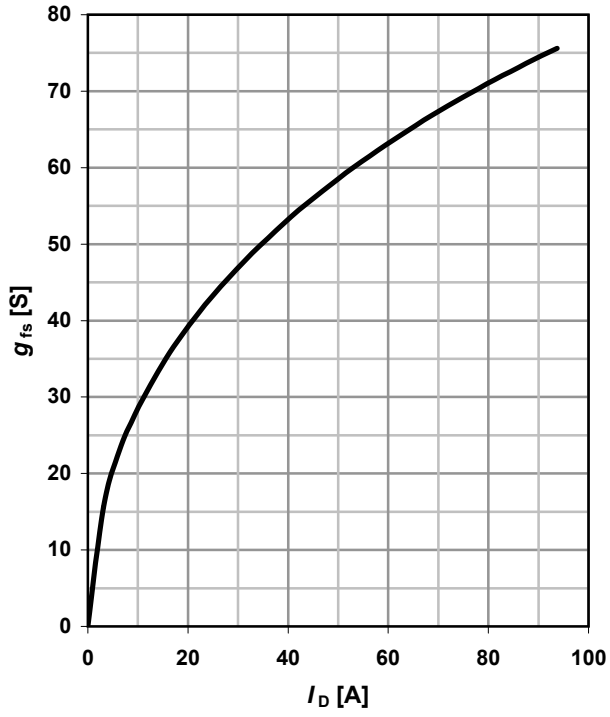
parameter: T_j



8 Typ. Forward transconductance

$g_{fs} = f(I_D)$; $T_j = 25$°C

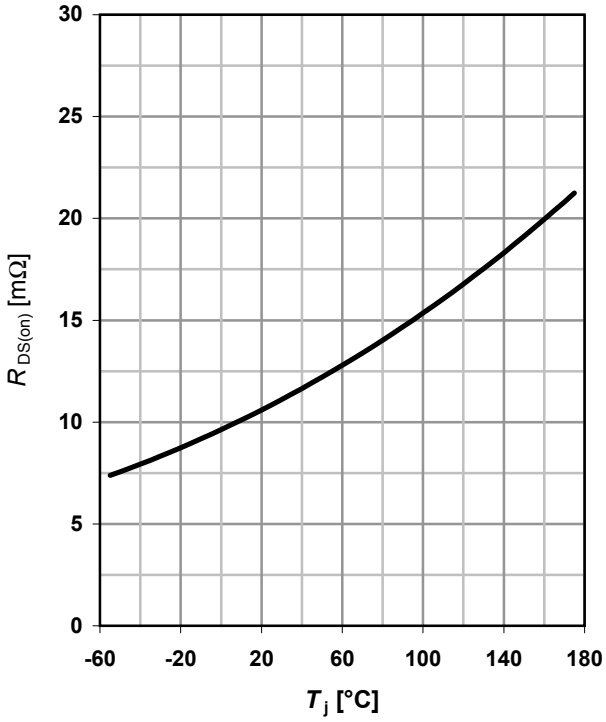
parameter: g_{fs}



9 Typ. Drain-source on-state resistance

$R_{DS(ON)} = f(T_j)$

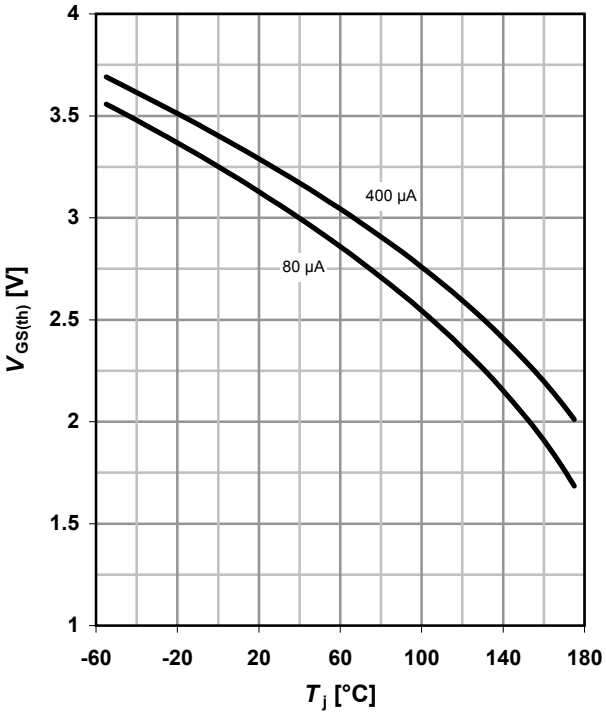
parameter: I_D = 32 A; V_{GS} = 10 V



10 Typ. gate threshold voltage

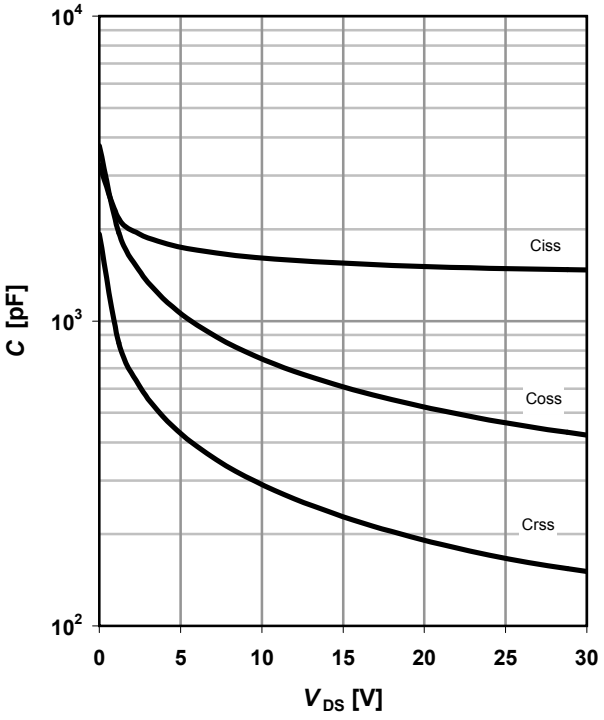
$V_{GS(th)} = f(T_j)$; $V_{GS} = V_{DS}$

parameter: I_D



11 Typ. capacitances

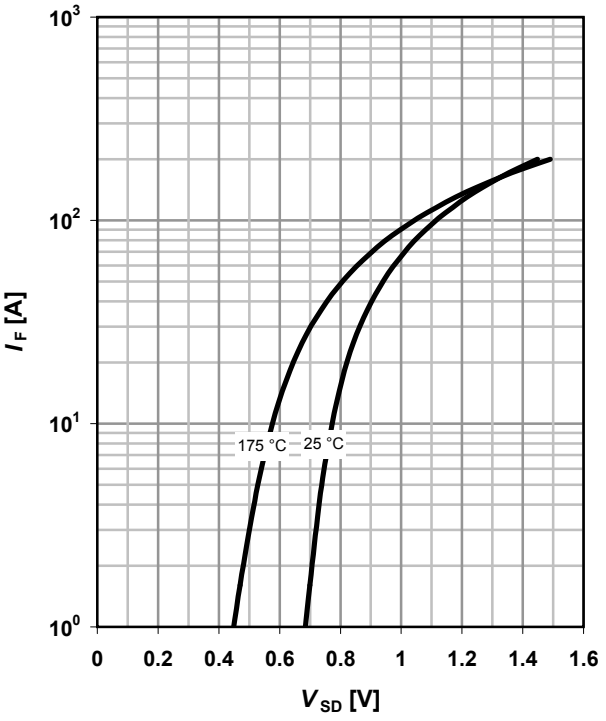
$C = f(V_{DS})$; V_{GS} = 0 V; f = 1 MHz



12 Typical forward diode characteristicis

IF = f(V_{SD})

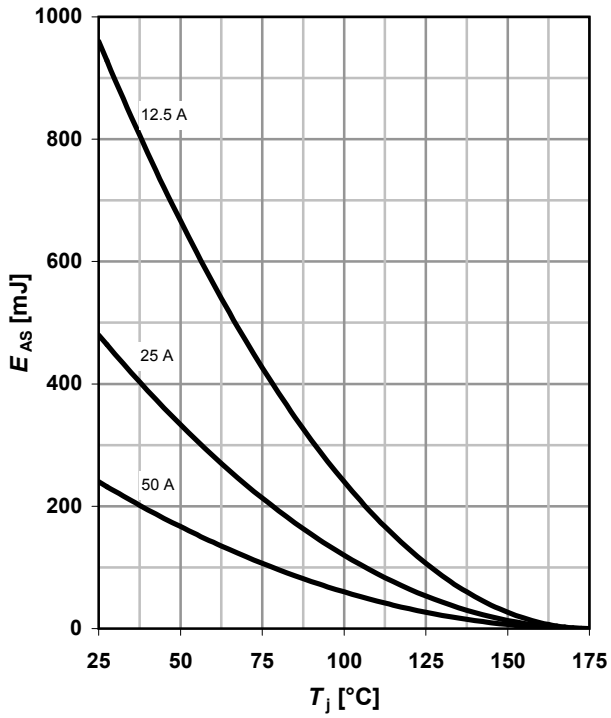
parameter: T_j



13 Typical avalanche energy

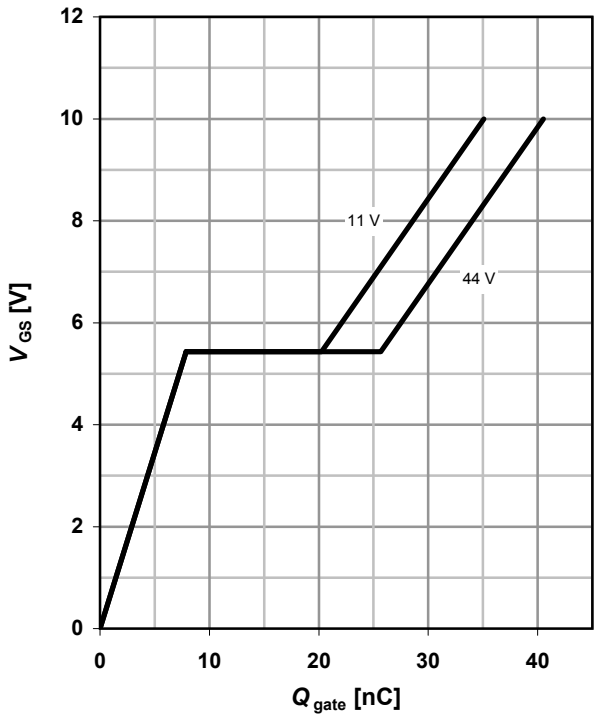
$E_{AS} = f(T_j)$

parameter: I_D



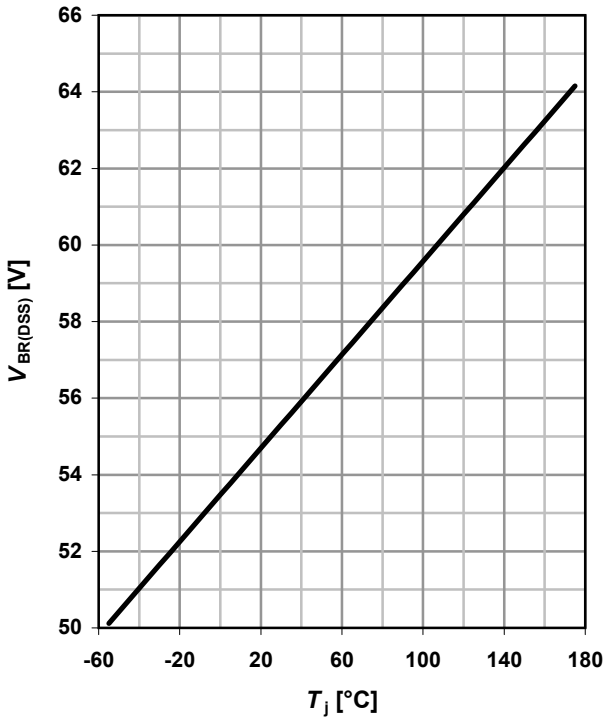
14 Typ. gate charge

$V_{GS} = f(Q_{gate})$; $I_D = 50$ A pulsed

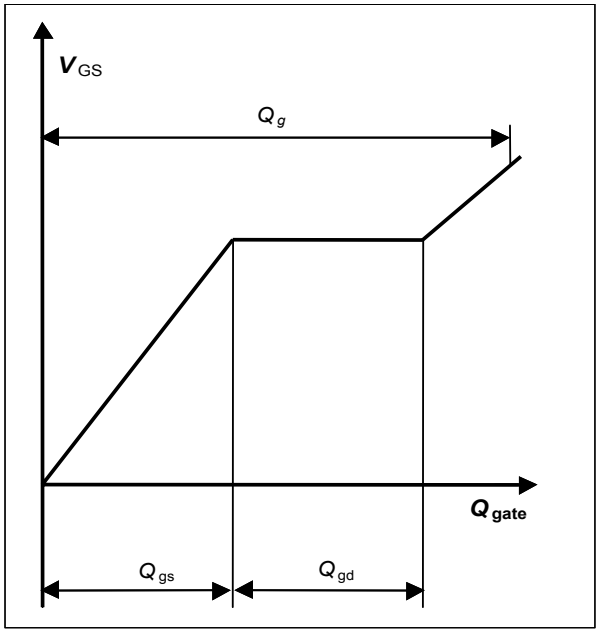


15 Typ. drain-source breakdown voltage

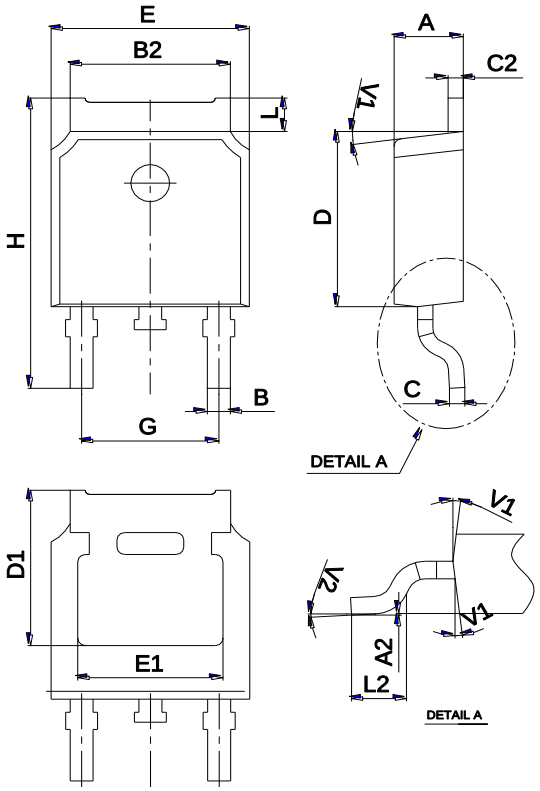
$V_{BR(DSS)} = f(T_j)$; $I_D = 1$ mA



16 Gate charge waveforms

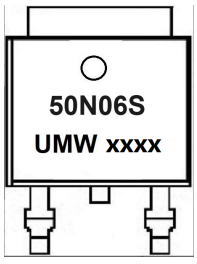


Package Mechanical Data TO-252



Ref.	Dimensions					
	Millimeters			Inches		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A	2.10		2.50	0.083		0.098
A2	0		0.10	0		0.004
B	0.66		0.86	0.026		0.034
B2	5.18		5.48	0.202		0.216
C	0.40		0.60	0.016		0.024
C2	0.44		0.58	0.017		0.023
D	5.90		6.30	0.232		0.248
D1	5.30REF			0.209REF		
E	6.40		6.80	0.252		0.268
E1	4.63			0.182		
G	4.47		4.67	0.176		0.184
H	9.50		10.70	0.374		0.421
L	1.09		1.21	0.043		0.048
L2	1.35		1.65	0.053		0.065
V1		7°			7°	
V2	0°		6°	0°		6°

Marking



Ordering information

Order code	Package	Baseqty	Deliverymode
UMW IPD50N06S2-14	TO-252	2500	Tape and reel